ES_LPC11U6x

Errata sheet LPC11U6x

Rev. 1 — 15 January 2014 **Errata sheet**

Document information

Info	Content
Keywords	LPC11U67JBD48; LPC11U68JBD48; LPC11U68JBD64; LPC11U68JBD100 LPC11U6x errata
Abstract	This errata sheet describes both the known functional problems and any deviations from the electrical specifications known at the release date of this document. Each deviation is assigned a number and its history is tracked in a table.

Revision history

Rev	Date	Description
1	20140115	• Initial version.

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1. Product identification

The LPC11U6x devices typically have the following top-side marking for LQFP100 packages:

LPC11U6xxxxxxx

Xxxxxx xx

xxxyywwxx

The LPC11U6x devices typically have the following top-side marking for LQFP64 packages:

LPC11U6xJ

Xxxxxx xx

xxxyywwxx

The LPC11U6x devices typically have the following top-side marking for LQFP48 packages:

LPC11U6xJ

Xxxxxx

Xxxyy

wwxx

The last letter in the last line identifies the device revision. This Errata Sheet covers the following revisions of the LPC11U6x:

Table 1. Device revision table

Revision identifier (R)	Revision description
'A'	Initial device revision

Field 'YY' states the year the device was manufactured. Field 'WW' states the week the device was manufactured during that year.

2. Errata overview

Table 2. Errata summary table

Functional problems	Short description	Revision identifier	Detailed description
USB_ROM.1	The USB ROM driver routine hwUSB_ResetEP() accidentally corrupts the subsequent word of memory while clearing the STALL bit of the selected endpoint.	'A'	Section 3.1
USB_ROM.2	The USBD ROM stack doesn't split EP0 transfer into multiple packets of 8 bytes (MAXP allowed) in low speed mode.	'A'	Section 3.2

Table 3. AC/DC deviations table

AC/DC deviations	Short description	Revision identifier	Detailed description
n/a	n/a	n/a	n/a

Table 4. Errata notes table

Errata notes	Short description	Revision identifier	Detailed description
n/a	n/a	n/a	n/a

3. Functional problems detail

3.1 USB_ROM.1

Introduction:

The on-chip USB2.0 full-speed device controller uses the USB endpoint (EP) Command/Status List organized in memory to store the EPs command/status information. Bit 29 indicates the STALL status of the corresponding EP. The USB ROM driver routine hwUSB_ResetEP(), which is called during SET_CONFIGURATION and SET_INTERFACE requests for all EPs present in the corresponding configuration/interface, clears the STALL bit of the selected EPs in Command/Status List as part of EP reset procedure.

Problem:

During the EP reset procedure executed by the USB ROM driver routine hwUSB_ResetEP(), it not only clears the STALL bit of the selected EP but also corrupts the subsequent word of memory. This issue is caused by a software bug in the hwUSB_ResetEP() routine.

Below is a summary of the runtime errors resulting from this issue:

- Case 1. When reset procedure is invoked on an EP which is at the end of the EP list, this bug will accidentally corrupt the memory area following the EP Command/Status List. In the current version of USB ROM driver this area is used for storing the receiver buffer address for control endpoint (EP0). This corruption causes erratic behavior on control OUT transaction.
- Case 2. When reset procedure is invoked on an EP which is in the beginning or middle of the EP list, this bug will accidentally clear the STALL bit of the subsequent EP in list.
  - If hwUSB_ResetEP() is called during SET_CONFIGURATION, clearing the STALL bit of the subsequent EP has no consequence since STALL condition is cleared for all EPs during SET_CONFIGURATION procedure.
  - If hwUSB_ResetEP() is called during SET_INTERFACE when selecting an ALT interface, this issue could clear STALL condition (if exists) on the subsequent EP. This condition is very rare.

Work-around:

The software work-around to address Case 1 is to specify one extra EP in the max_num_ep field of the USBD_API_INIT_PARAM_T structure passed to the ROM driver's hw->init() routine. This extra EP provides a padding buffer to avoid corruption to the subsequent word of memory. This workaround is demonstrated with the line of code highlighted in red in function usb_init() in the following example.

If your system is affected with Case 2, user should check the "ep_halt" member of USB_CORE_CTRL_T structure in the SET_INTERFACE event and set STALL bit for any EP which got cleared due to this bug. This condition is very rare. This workaround is demonstrated with the function StallWorkAround () in the following example. Notice that StallWorkAround is set to be an interface event in the usb_init() function (highlighted in bold).

```
ErrorCode_t StallWorkAround(USBD_HANDLE_T hUsb)
{
      ErrorCode_t ret = LPC_OK;
      USB_CORE_CTRL_T *pCtrl = (USB_CORE_CTRL_T *) hUsb;
      EP_Queue_T *epQueue;
      int32_t i;

      /*    WORKAROUND for Case 2:
      Code clearing STALL bits in endpoint reset routine corrupts memory area
          next to the endpoint control data.
      */
      if (pCtrl->ep_halt != 0) { /* check if STALL is set for any endpoint */
            /* get pointer to HW EP queue */
            epQueue = (EP_Queue_T *) LPC_USB->EPLISTSTART;
            /* check if the HW STALL bit for the endpoint is cleared due to bug. */
            for (i = 1; i < pCtrl->max_num_ep; i++) {
                  /* check OUT EPs */
                  if ( pCtrl->ep_halt & (1 << i)) {
                        /* Check if HW EP queue also has STALL bit = _BIT(29) is set */
                         if (( epQueue[i << 1].td[0] & _BIT(29)) == 0) {
                               /* bit not set, cleared by BUG. So set it back. */
                               epQueue[i << 1].td[0] |= _BIT(29);
                         }
                  }
                  /* Check IN EPs */
                  if ( pCtrl->ep_halt & (1 << (i + 16))) {
                        /* Check if HW EP queue also has STALL bit = _BIT(29) is set */
                         if (( epQueue[(i << 1) + 1].td[0] & _BIT(29)) == 0) {
                               /* bit not set, cleared by BUG. So set it back. */
                               epQueue[(i << 1) + 1].td[0] |= _BIT(29);
                         }
                  }
            }
      }

      return ret;
}

/* Initialize USB sub system */
static ErrorCode_t usbd_init(void)
{
      USBD_API_INIT_PARAM_T usb_param;
      USB_CORE_DESCS_T desc;
      ADC_INIT_PARAM_T adc_param;
      ErrorCode_t ret = LPC_OK;

      /* enable clocks and pinmux */
      usb_pin_clk_init();

      /* initialize USBD ROM API pointer. */
      g_pUsbApi = (const USBD_API_T *) LPC_ROM_API->usbdApiBase;
```

```
        /* initialize call back structures */
        memset((void *) &usb_param, 0, sizeof(USBD_API_INIT_PARAM_T));
        usb_param.usb_reg_base = LPC_USB0_BASE;
        /*  WORKAROUND for Case 1
       For example When EP0, EP1_IN, EP1_OUT and EP2_IN are used we need to specify
       usb_param.max_num_ep as 3 here. But as a workaround for this issue specify
       usb_param.max_num_ep as 4. So that extra EPs control structure acts as padding
       buffer to avoid data corruption. Corruption of padding memory doesn't affect the
       stack/program behavior.
        */
        usb_param.max_num_ep = 3 + 1;
        usb_param.USB_Interface_Event = StallWorkAround;

        usb_param.mem_base = USB_STACK_MEM_BASE;
        usb_param.mem_size = USB_STACK_MEM_SIZE;

        /* Set the USB descriptors */
        desc.device_desc = (uint8_t *) &USB_DeviceDescriptor[0];
        desc.string_desc = (uint8_t *) &USB_StringDescriptor[0];
        /* Note, to pass USBCV test full-speed only devices should have both
           descriptor arrays point to same location and device_qualifier set to 0.
        */
        desc.high_speed_desc = (uint8_t *) &USB_FsConfigDescriptor[0];
        desc.full_speed_desc = (uint8_t *) &USB_FsConfigDescriptor[0];
        desc.device_qualifier = 0;

        /* USB Initialization */
        ret = USBD_API->hw->Init(&g_hUsb, &desc, &usb_param);
        if (ret == LPC_OK) {
…
}
```

3.2 USB_ROM.2

Introduction:

When USB device operates in low-speed mode the maximum packet length (MAXP) for control transfer and interrupt transfers is restricted to 8 bytes. Hence when more than 8 bytes needs to be transferred, the data should be split into multiple 8 byte packets. But the current ROM stack splits the control transfer into multiples of 64 bytes only.

Problem:

Device will not enumerate when used in low-speed mode.

Work-around:

The software work-around for this issue is to override the cases where the ROM stack would queue a large transfer and split them into smaller 8 byte packet transfers. Since low speed USB allows only interrupt endpoints, a workaround for HID class implementation is shown below:

```
static ErrorCode_t HID_LowSpeedPatch(USBD_HANDLE_T hUsb, void *data, uint32_t event)
{
      USB_CORE_CTRL_T *pCtrl = (USB_CORE_CTRL_T *) hUsb;
      USB_HID_CTRL_T *pHidCtrl = (USB_HID_CTRL_T *) data;
      ErrorCode_t ret = ERR_USBD_UNHANDLED;
      uint16_t cnt = 0, len = 0;

      switch (event) {
      case USB_EVT_SETUP:
            if (pCtrl->SetupPacket.bmRequestType.BM.Type == REQUEST_STANDARD) {

                  switch (pCtrl->SetupPacket.bRequest) {
                  case USB_REQUEST_GET_DESCRIPTOR:
                        /* handle HID descriptors first */
                        switch (pCtrl->SetupPacket.wValue.WB.H) {
                        case HID_HID_DESCRIPTOR_TYPE:
                              pCtrl->EP0Data.pData = pHidCtrl->hid_desc;
                              len = ((USB_COMMON_DESCRIPTOR *)
                              pHidCtrl->hid_desc)->bLength;
                              ret = LPC_OK;
                              break;

                        case HID_REPORT_DESCRIPTOR_TYPE:
                              ret = pHidCtrl->HID_GetReportDesc(pHidCtrl,
                              &pCtrl->SetupPacket,
                              &pCtrl->EP0Data.pData, &len);
                              break;

                        case HID_PHYSICAL_DESCRIPTOR_TYPE:
                              if (pHidCtrl->HID_GetPhysDesc == 0) {
                              ret = (ERR_USBD_STALL); /* HID Physical Descriptor is not
                              supported */
                              }
                              else {
```

```
                                    ret = pHidCtrl->HID_GetPhysDesc(pHidCtrl,
                                    &pCtrl->SetupPacket,&pCtrl->EP0Data.pData, &len);
                               }
                               break;

                          default:
                               ret = pCtrl->USB_ReqGetDescriptor(pCtrl);
                               break;
                          }
                          break;

                     case USB_REQUEST_GET_CONFIGURATION:
                          ret = pCtrl->USB_ReqGetConfiguration(pCtrl);
                          break;

                     case USB_REQUEST_GET_INTERFACE:
                          ret = pCtrl->USB_ReqGetInterface(pCtrl);
                          break;

                     default:
                          break;
                     }
                }
                else if ((pCtrl->SetupPacket.bmRequestType.BM.Type == REQUEST_CLASS) &&
                          (pCtrl->SetupPacket.bmRequestType.BM.Recipient ==
REQUEST_TO_INTERFACE) &&
                          pCtrl->SetupPacket.bRequest == HID_REQUEST_GET_REPORT) ) {

                     pCtrl->EP0Data.pData = pCtrl->EP0Buf; /* point to data to be sent */
                     /* allow user to copy data to EP0Buf or change the pointer to his own
                     buffer */
                     ret = pHidCtrl->HID_GetReport(pHidCtrl, &pCtrl->SetupPacket,
                          &pCtrl->EP0Data.pData, &pCtrl->EP0Data.Count);
                }
                break;

           case USB_EVT_IN:
                if (pCtrl->SetupPacket.bmRequestType.BM.Dir == REQUEST_DEVICE_TO_HOST) {
                     ret = LPC_OK;
                }
                break;

           }
           if (ret == LPC_OK) {
                if ((len != 0) && (pCtrl->EP0Data.Count > len)) {
                     pCtrl->EP0Data.Count = len;
                }
                cnt = (pCtrl->EP0Data.Count > USB_MAX_PACKET0) ? USB_MAX_PACKET0 :
                pCtrl->EP0Data.Count;
                cnt = USBD_API->hw->WriteEP(pCtrl, 0x80, pCtrl->EP0Data.pData, cnt);
                pCtrl->EP0Data.pData += cnt;
```

```
            pCtrl->EP0Data.Count -= cnt;
        }
        else if (ret == ERR_USBD_UNHANDLED) {
            ret = g_defaultHidHdlr(hUsb, data, event);
        }

        return ret;
}
```

To install this patch handler do the following:

- declare a global variable

```
static USB_EP_HANDLER_T g_defaultHidHdlr;
```

- Install the override handler during initialization phase.

```
        ret = USBD_API->hid->init(hUsb, &hid_param);
        if (ret == LPC_OK) {
            /*          WORKAROUND for artf49378 */
            g_defaultHidHdlr = pCtrl->ep0_hdlr_cb[pCtrl->num_ep0_hdlrs - 1];
            /* store the default CDC handler and replace it with ours */
            pCtrl->ep0_hdlr_cb[pCtrl->num_ep0_hdlrs - 1] = HID_LowSpeedPatch;

....
}
```

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